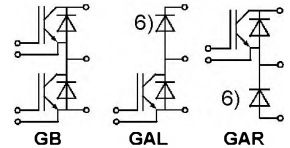


SEMİTRANS® M IGBT Modules

SKM 300 GB 123 D
SKM 300 GAL 123 D ⁶⁾
SKM 300 GAR 123 D ⁶⁾



SEMİTRANS 3



Features

- MOS input (voltage controlled)
 - N channel, Homogeneous Si
 - Low inductance case
 - Very low tail current with low temperature dependence
 - High short circuit capability, self limiting to $6 \cdot I_{cnom}$
 - Latch-up free
 - Fast & soft inverse CAL diodes⁸⁾
 - Isolated copper baseplate using DCB Direct Copper Bonding Technology
 - Large clearance (12 mm) and creepage distances (20 mm)
- Typical Applications:** → B6 - 79
- Switching, not for linear use
 - AC-inverter drives
 - UPS

¹⁾ $T_{case} = 25\text{ }^\circ\text{C}$, unless otherwise specified

²⁾ $I_F = -I_C$, $V_R = 600\text{ V}$, $-di/dt = 2000\text{ A}/\mu\text{s}$, $V_{GE} = 0\text{ V}$

³⁾ Use $V_{Goff} = -5 \dots -15\text{ V}$

⁵⁾ see fig. 2 + 3; $R_{Goff} = 4,7\ \Omega$

⁶⁾ The free-wheeling diodes of the GAL and GAR types have the data of the inverse diodes of SKM 400 GA 123 D

⁸⁾ CAL = Controlled Axial Lifetime Technology.

Cases and mech. data → B6-100 SEMİTRANS 3

| Absolute Maximum Ratings | | Values | | Units |
|--------------------------|--|---------------------|-------------------|----------------------|
| Symbol | Conditions ¹⁾ | | | |
| V_{CES} | | 1200 | | V |
| V_{CGR} | $R_{GE} = 20\text{ k}\Omega$ | 1200 | | V |
| I_C | $T_{case} = 25/80\text{ }^\circ\text{C}$ | 290 / 200 | | A |
| I_{CM} | $T_{case} = 25/80\text{ }^\circ\text{C}$; $t_p = 1\text{ ms}$ | 580 / 400 | | A |
| V_{GES} | | ± 20 | | V |
| P_{tot} | per IGBT, $T_{case} = 25\text{ }^\circ\text{C}$ | 1400 | | W |
| T_j , (T_{stg}) | | - 40 ... +150 (125) | | $^\circ\text{C}$ |
| V_{isol} | AC, 1 min. | 2 500 | | V |
| humidity | DIN 40 040 | Class F | | |
| climate | DIN IEC 68 T.1 | 55/150/56 | | |
| Inverse Diode | | | | |
| $I_F = -I_C$ | $T_{case} = 25/80\text{ }^\circ\text{C}$ | 260 / 180 | FWD ⁶⁾ | A |
| $I_{FM} = -I_{CM}$ | $T_{case} = 25/80\text{ }^\circ\text{C}$; $t_p = 1\text{ ms}$ | 600 / 400 | 580 / 400 | A |
| I_{FSM} | $t_p = 10\text{ ms}$; $\sin.$; $T_j = 150\text{ }^\circ\text{C}$ | 2200 | 2900 | A |
| t_t | $t_p = 10\text{ ms}$; $T_j = 150\text{ }^\circ\text{C}$ | 24200 | 42000 | A^2s |

| Characteristics | | min. | typ. | max. | Units |
|--|--|----------------|-----------|-----------|---------------------------|
| Symbol | Conditions ¹⁾ | | | | |
| $V_{I(BR)CES}$ | $V_{GE} = 0$, $I_C = 4\text{ mA}$ | $\geq V_{CES}$ | - | - | V |
| $V_{GE(th)}$ | $V_{GE} = V_{CES}$, $I_C = 8\text{ mA}$ | 4,5 | 5,5 | 6,5 | V |
| I_{CES} | $V_{GE} = 0$ $T_j = 25\text{ }^\circ\text{C}$ | - | 3 | 4,5 | mA |
| | $V_{CE} = V_{CES}$ $T_j = 125\text{ }^\circ\text{C}$ | - | 15 | - | mA |
| I_{GES} | $V_{GE} = 20\text{ V}$, $V_{CE} = 0$ | - | - | 0,4 | μA |
| V_{CESat} | $I_C = 200\text{ A}$ $V_{GE} = 15\text{ V}$; | - | 2,5(3,1) | 3(3,7) | V |
| V_{CESat} | $I_C = 300\text{ A}$ $T_j = 25\text{ (125) }^\circ\text{C}$ | - | 3(3,8) | - | V |
| g_{fs} | $V_{CE} = 20\text{ V}$, $I_C = 200\text{ A}$ | 108 | 150 | - | S |
| C_{CHC} | per IGBT | - | - | 700 | pF |
| C_{ies} | $V_{GE} = 0$ | - | 18 | 24 | nF |
| C_{oes} | $V_{CE} = 25\text{ V}$ | - | 2,5 | 3,2 | nF |
| C_{res} | $f = 1\text{ MHz}$ | - | 1,0 | 1,3 | nF |
| L_{CE} | | - | - | 20 | nH |
| $t_{d(on)}$ | $V_{CC} = 600\text{ V}$ | - | 250 | 400 | ns |
| t_r | $V_{GE} = +15\text{ V} / -15\text{ V}^{3)}$ | - | 90 | 160 | ns |
| $t_{d(off)}$ | $I_C = 200\text{ A}$, ind. load | - | 550 | 700 | ns |
| t_f | $R_{Gon} = R_{Goff} = 4,7\ \Omega$ | - | 70 | 100 | ns |
| $E_{on}^{5)}$ | $T_j = 125\text{ }^\circ\text{C}$ | - | 28 | - | mWs |
| $E_{off}^{5)}$ | | - | 26 | - | mWs |
| Inverse Diode ⁸⁾ | | | | | |
| $V_F = V_{EC}$ | $I_F = 200\text{ A}$ $V_{GE} = 0\text{ V}$; | - | 2,0(1,8) | 2,5 | V |
| $V_F = V_{EC}$ | $I_F = 300\text{ A}$ $T_j = 25\text{ (125) }^\circ\text{C}$ | - | 2,25(2,1) | - | V |
| V_{TO} | $T_j = 125\text{ }^\circ\text{C}$ | - | 1,1 | 1,2 | V |
| r_T | $T_j = 125\text{ }^\circ\text{C}^{2)}$ | - | 3 | 5,5 | m Ω |
| I_{RRM} | $I_F = 200\text{ A}$; $T_j = 25\text{ (125) }^\circ\text{C}^{2)}$ | - | 70(105) | - | A |
| Q_{rr} | $I_F = 200\text{ A}$; $T_j = 25\text{ (125) }^\circ\text{C}^{2)}$ | - | 10(26) | - | μC |
| FWD of type "GAL" and "GAR" ⁸⁾⁶⁾ | | | | | |
| $V_F = V_{EC}$ | $I_F = 200\text{ A}$ $V_{GE} = 0\text{ V}$; | - | 1,9(1,7) | 2,4 | V |
| $V_F = V_{EC}$ | $I_F = 300\text{ A}$ $T_j = 25\text{ (125) }^\circ\text{C}$ | - | 2,1(1,8) | - | V |
| V_{TO} | $T_j = 125\text{ }^\circ\text{C}$ | - | - | 1,2 | V |
| r_T | $T_j = 125\text{ }^\circ\text{C}$ | - | 3 | 3,5 | m Ω |
| I_{RRM} | $I_F = 200\text{ A}$; $T_j = 25\text{ (125) }^\circ\text{C}^{2)}$ | - | 80(140) | - | ns |
| Q_{rr} | $I_F = 200\text{ A}$; $T_j = 25\text{ (125) }^\circ\text{C}^{2)}$ | - | 10(34) | - | μC |
| Thermal Characteristics | | | | | |
| R_{thjc} | per IGBT | - | - | 0,09 | $^\circ\text{C}/\text{W}$ |
| R_{thjc} | per diode / FWD ⁶⁾ | - | - | 0,18/0,15 | $^\circ\text{C}/\text{W}$ |
| R_{thch} | per module | - | - | 0,038 | $^\circ\text{C}/\text{W}$ |

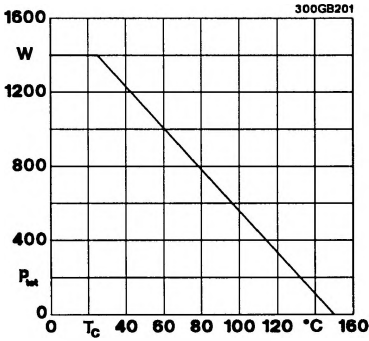


Fig. 1 Rated power dissipation $P_{tot} = f(T_c)$

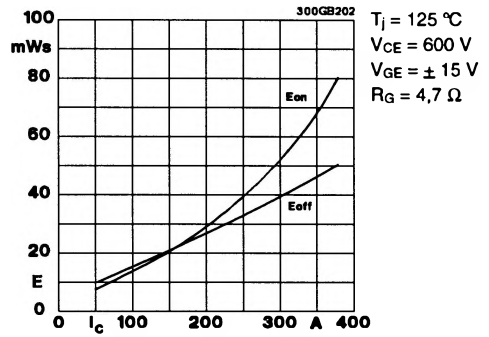


Fig. 2 Turn-on /-off energy $= f(I_c)$

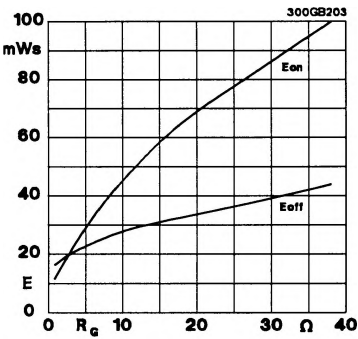


Fig. 3 Turn-on /-off energy $= f(R_G)$

$T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $I_c = 200\text{ A}$

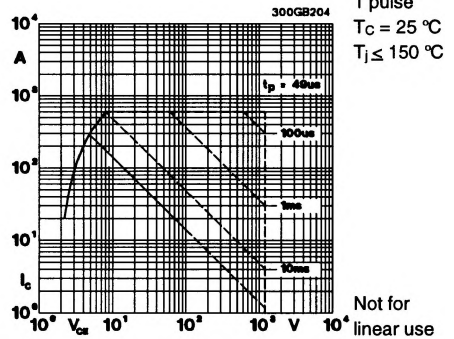


Fig. 4 Maximum safe operating area (SOA) $I_c = f(V_{ce})$

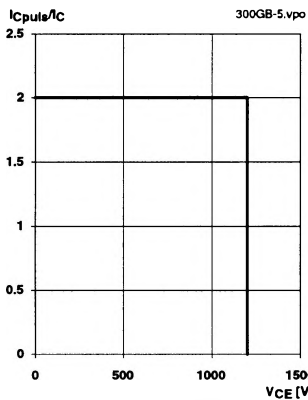


Fig. 5 Turn-off safe operating area (RBSOA)

$T_j \leq 150\text{ }^\circ\text{C}$
 $V_{GE} = 15\text{ V}$
 $R_{G(off)} = 4,7\ \Omega$
 $I_c = 200\text{ A}$

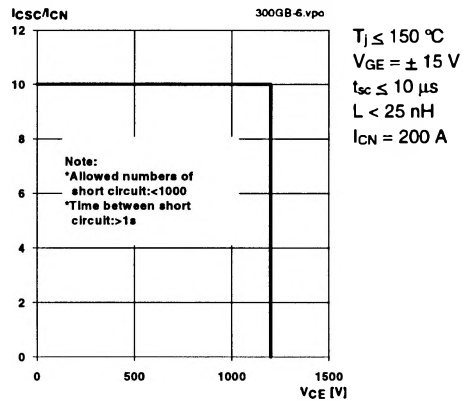


Fig. 6 Safe operating area at short circuit $I_c = f(V_{ce})$

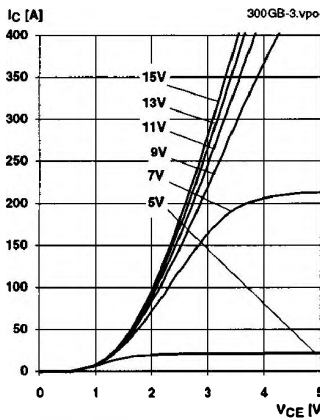


Fig. 9 Typ. output characteristic, $t_p = 80 \mu s$; $25 \text{ }^\circ\text{C}$

$$P_{\text{cond}(t)} = V_{\text{CEsat}(t)} \cdot I_{\text{C}}(t)$$

$$V_{\text{CEsat}(t)} = V_{\text{CE(TO)(Tj)}} + r_{\text{CE(Tj)}} \cdot I_{\text{C}}(t)$$

$$V_{\text{CE(TO)(Tj)}} \leq 1,5 + 0,002 (T_j - 25) \text{ [V]}$$

$$r_{\text{CE(Tj)}} = 0,005 + 0,00002 (T_j - 25) \text{ [\Omega]}$$

$$\text{valid for } V_{\text{GE}} = +15 \begin{matrix} +2 \\ -1 \end{matrix} \text{ [V]; } I_{\text{C}} > 0,3 I_{\text{Cnom}}$$

Fig. 11 Typ. saturation characteristic (IGBT)
Calculation elements and equations

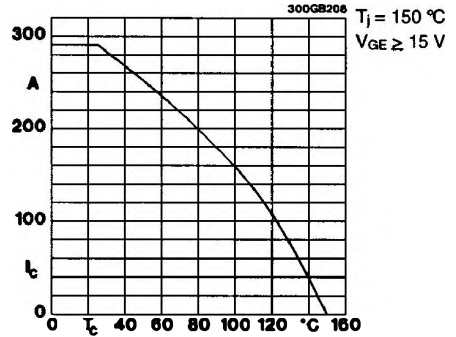


Fig. 8 Rated current vs. temperature $I_{\text{C}} = f(T_{\text{C}})$

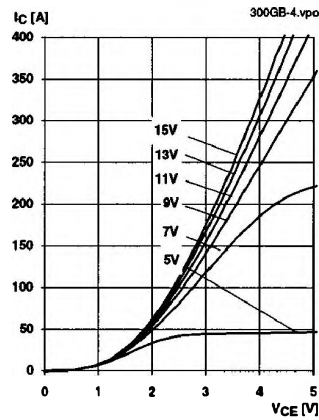


Fig. 10 Typ. output characteristic, $t_p = 80 \mu s$; $125 \text{ }^\circ\text{C}$

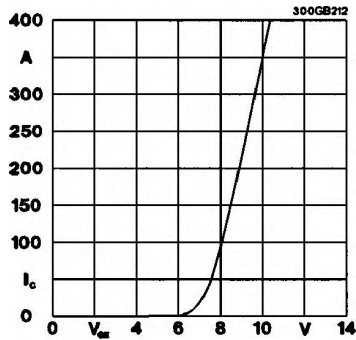


Fig. 12 Typ. transfer characteristic, $t_p = 80 \mu s$; $V_{\text{CE}} = 20 \text{ V}$

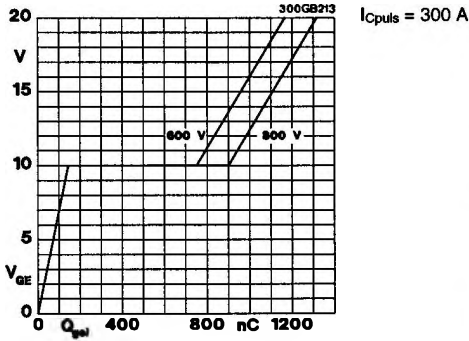


Fig. 13 Typ. gate charge characteristic

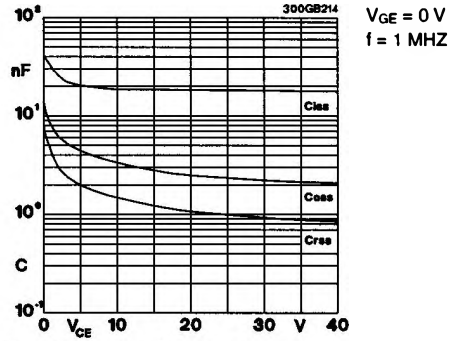


Fig. 14 Typ. capacitances vs. V_{CE}

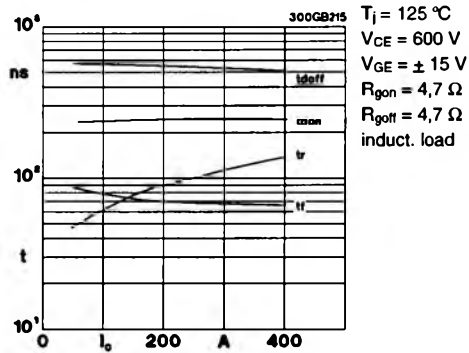


Fig. 15 Typ. switching times vs. I_C

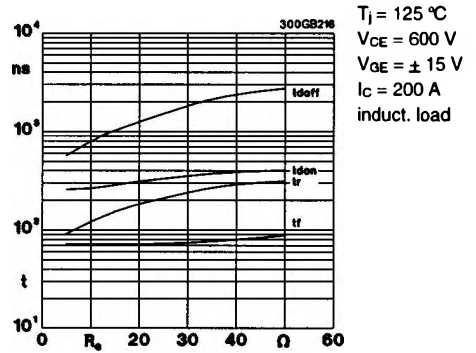


Fig. 16 Typ. switching times vs. gate resistor R_g

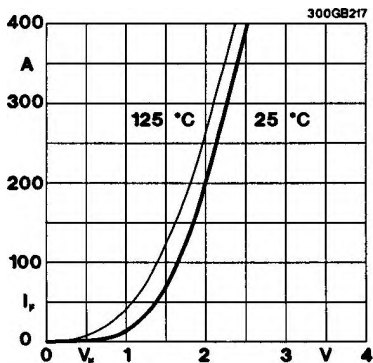


Fig. 17 Typ. CAL diode forward characteristic

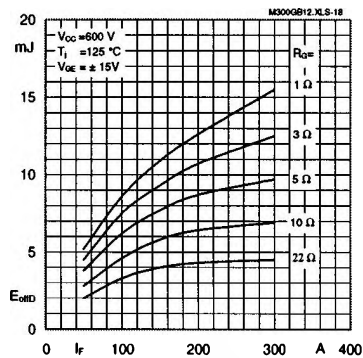


Fig. 18 Diode turn-off energy dissipation per pulse

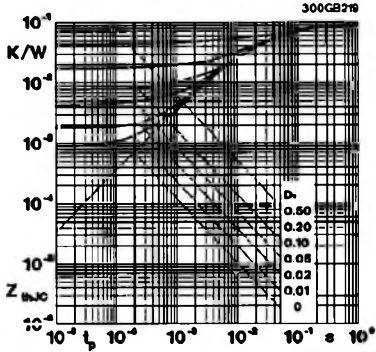


Fig. 19 Transient thermal impedance of IGBT $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

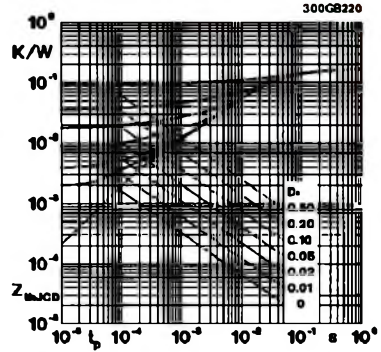


Fig. 20 Transient thermal impedance of inverse CAL diodes $Z_{thCD} = f(t_p)$;

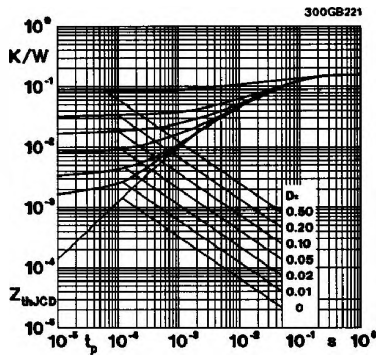


Fig. 21 Transient thermal impedance of the freewheeling diode $Z_{thCD} \rightarrow B 6 - 95, \text{ rem. } 6)$

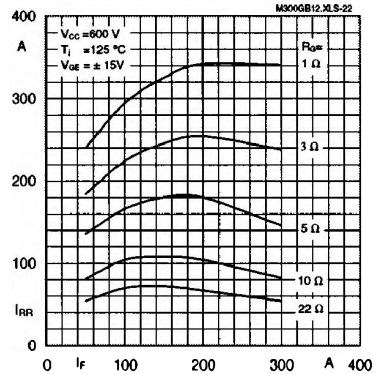


Fig. 22 Typ. CAL diode reverse recovery current $I_{RR} = f(I_F, R_G)$

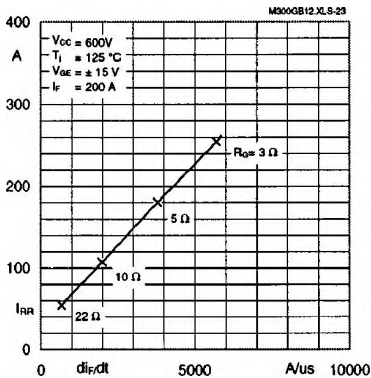


Fig. 23 Typ. CAL diode reverse recovery current $I_{RR} = f(di_F/dt; R_G)$

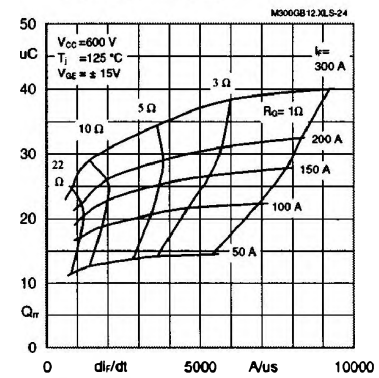
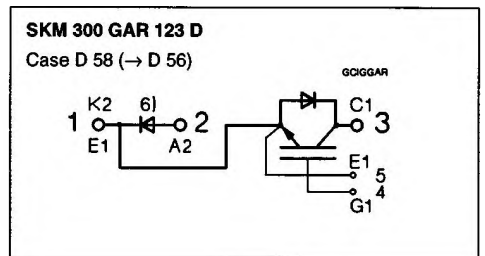
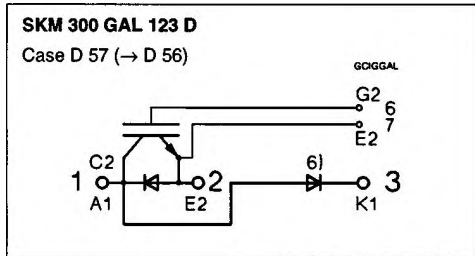
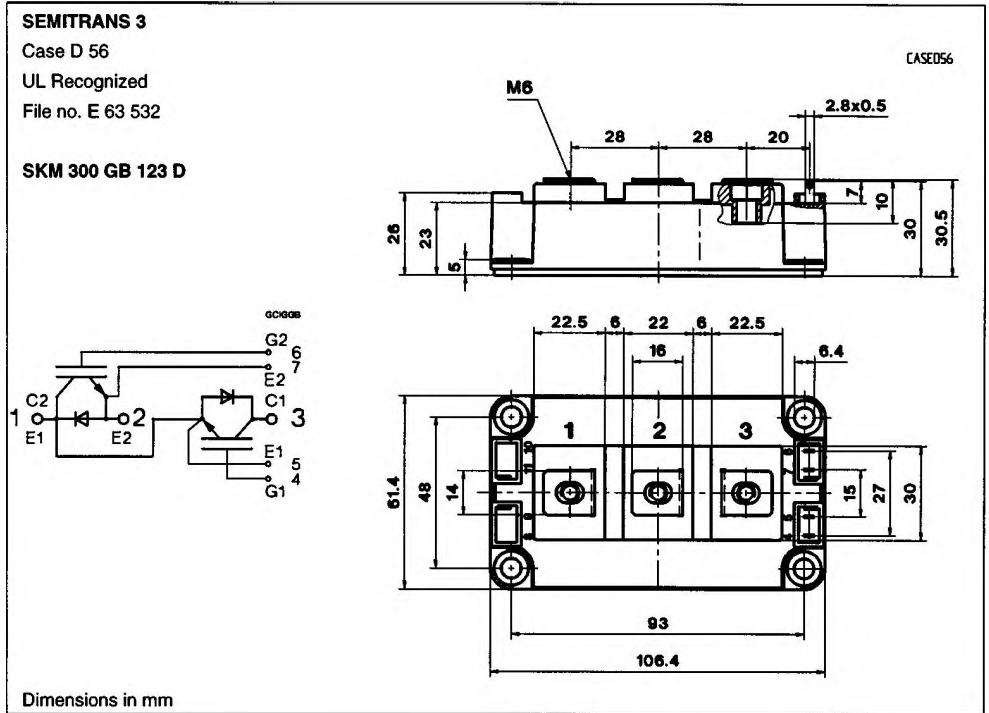


Fig. 24 Typ. CAL diode recovered charge $Q_{rr} = f(di_F/dt; I_F; R_G)$



Case outline and circuit diagrams

| Mechanical Data | | Values | | | Units |
|-----------------|---|-------------|------|--------|------------------|
| Symbol | Conditions | min. | typ. | max. | |
| M ₁ | to heatsink, SI Units to heatsink, US Units | (M6) 3 | — | 5 | Nm lb.in. |
| M ₂ | for terminals, SI Units for terminals US Units | (M6) 2,5 | — | 5 | Nm lb.in. |
| a | | — | — | 5x9,81 | m/s ² |
| w | | — | — | 420 | g |

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Three devices are supplied in one SEMIBOX A without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 3). Larger packing units of 12 and 20 pieces are used if suitable

Accessories → page B 6 - 4.
 SEMIBOX → page C - 1.

⁶⁾ Freewheeling diode → page B 6 - 95, remark 6.